




<b>Searched</b> 	Application/Control No.  10028825	Applicant(s)/Patent Under Reexamination  YAMASAKI ET AL.
	Examiner Tran, Mai T	Art Unit 2129

Class	SubClass	Date	Examiner
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U.S. Patent and Trademark Office	Part of Paper No.: 08142006
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<b>Search Notes</b>  	Application/Control No.  10028825	Applicant(s)/Patent Under Reexamination  YAMASAKI ET AL.
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Notes	Date	Examiner
EAST (Please see search history printout)	8/16/2006	mtt
Plus Search (PLease see search results printout)	8/3/2006	mtt
U.S. Patent and Trademark Office		Part of Paper No.: 08142006

<b><i>Interference Searched</i></b> 	Application/Control No.  10028825	Applicant(s)/Patent Under Reexamination  YAMASAKI ET AL.
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